

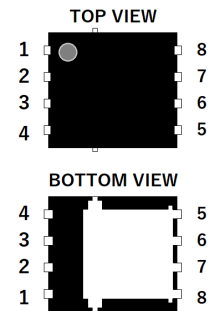
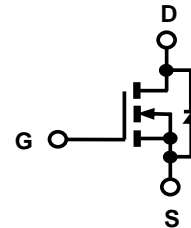
ICE6N60LK N-Channel Enhancement Mode MOSFET

Features

- Low $r_{DS(on)}$
- Ultra Low Gate Charge
- High dv/dt capability
- High Unclamped Inductive Switching (UIS) capability
- High peak current capability
- Increased transconductance performance
- Optimized design for high performance power systems



Product Summary			
I_D	$T_A=25^\circ\text{C}$	6A	Max
$V_{(BR)DSS}$	$I_D=250\mu\text{A}$	600V	Min
$r_{DS(on)}$	$V_{GS}=10\text{V}$	0.60	Typ
Q_g	$V_{DS}=480\text{V}$	28nC	Typ



DFN5x6

1-3=Source

4=Gate, 5-8=Drain

ICEMOS OWNS THE FUNDAMENTAL PATENTS FOR SUPERJUNCTION MOSFETS. THE MAJORITY OF THESE PATENTS HAVE 17 to 20 YEARS OF REMAINING LIFE. THIS PORTFOLIO HAS GRANTED PATENTS ISSUED IN USA, CHINA, KOREA, JAPAN, TAIWAN & EUROPE.

Maximum ratings^b at $T_j=25^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	I_D	$T_c=25^\circ\text{C}$	6	A
		$T_c=100^\circ\text{C}$	4	
Pulsed drain current	$I_{D, pulse}$	$T_c=25^\circ\text{C}$	18	A
Avalanche energy, single pulse	E_{AS}	$I_D=4.8\text{A}$	115	mJ
Avalanche current, repetitive	I_{AR}	limited by $T_{j,max}$	4.8	A
MOSFET dv/dt ruggedness	dv/dt	$V_{DS}=480\text{V}$, $I_D=6\text{A}$, $T_j=125^\circ\text{C}$	50	V/ns
Gate source voltage	V_{GS}	Static	± 20	V
		AC ($f>1\text{Hz}$)	± 30	
Power dissipation	P_{tot}	$T_c=25^\circ\text{C}$	78	W
Operating and storage temperature	T_j, T_{stg}		-55 to +150	$^\circ\text{C}$

a When mounted on 1inch square 2oz copper clad FR-4

b limited by $T_{j,max}$

Parameter	Symbol	Conditions	Values			Unit
			Min	Typ	Max	
Thermal characteristics						
Thermal resistance, junction-case ^a	R_{thJC}		-	-	1.6	°C/W
Thermal resistance, junction-ambient ^a	R_{thJA}	leaded	-	-	62	
Soldering temperature, wave soldering only allowed at leads	T_{sold}	1.6mm (0.063in.) from case for 10 s	-	-	260	°C

Electrical characteristics at $T_j=25^\circ\text{C}$, unless otherwise specified

Static characteristics

Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{GS}=0\text{ V}, I_D=250\mu\text{A}$	600	640	-	V
Gate threshold voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	2.1	3.0	3.9	
Zero gate voltage drain current	I_{DSS}	$V_{DS}=600\text{V}, V_{GS}=0\text{V}, T_j=25^\circ\text{C}$	-	0.1	1	μA
		$V_{DS}=600\text{V}, V_{GS}=0\text{V}, T_j=150^\circ\text{C}$	-	100	-	
Gate source leakage current	I_{GSS}	$V_{GS}=\pm 20\text{ V}, V_{DS}=0\text{V}$	-	-	100	nA
Drain-source on-state resistance	$R_{DS(on)}$	$V_{GS}=10\text{V}, I_D=3\text{A}, T_j=25^\circ\text{C}$	-	0.60	0.70	Ω
		$V_{GS}=10\text{V}, I_D=3\text{A}, T_j=150^\circ\text{C}$	-	1.60	-	
Gate resistance	R_G	$f=1\text{ MHz}, \text{open drain}$	-	3.8	-	Ω

Dynamic characteristics

Input capacitance	C_{iss}	$V_{GS}=0\text{ V}, f=1\text{ MHz}$	$V_{DS}=25\text{ V}$	-	579	-	μF
Output capacitance	C_{oss}		$V_{DS}=100\text{ V}$	-	26	-	
Reverse transfer capacitance	C_{rss}		$V_{DS}=25\text{ V}$	-	12	-	
Transconductance	g_{fs}	$V_{DS}>2 * I_D * R_{DS}, I_D=3\text{A}$		-	4	-	S
Turn-on delay time	$t_{d(on)}$	$V_{DS}=380\text{V}, V_{GS}=10\text{V}, I_D=3\text{A}, R_G=4\Omega \text{ (External)}$		-	14	-	ns
Rise time	t_r			-	6	-	
Turn-off delay time	$t_{d(off)}$			-	42	-	
Fall time	t_f			-	5.2	-	

Parameter	Symbol	Conditions	Values			Unit
			Min	Typ	Max	

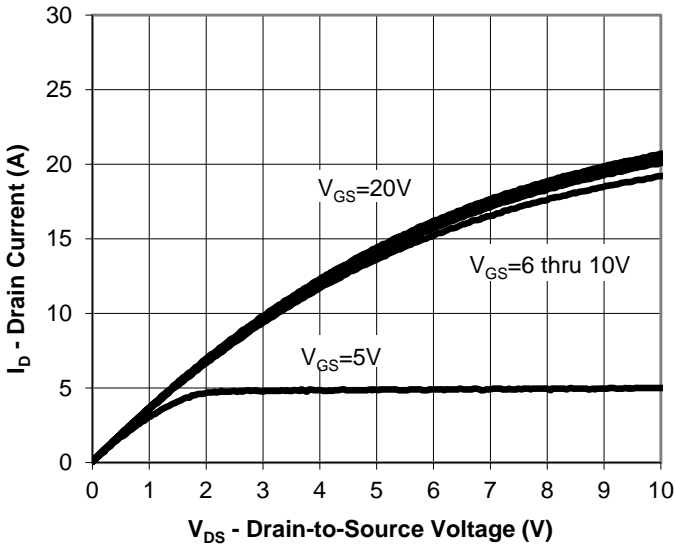
Gate charge characteristics

Gate to source charge	Q_{gs}	$V_{DS}=480\text{ V}, I_D=6\text{ A},$ $V_{GS}=0\text{ to }10\text{ V}$	-	3	-	nC
Gate to drain charge	Q_{gd}		-	7	-	
Gate charge total	Q_g		-	28	-	
Gate plateau voltage	$V_{plateau}$		-	5.4	-	V

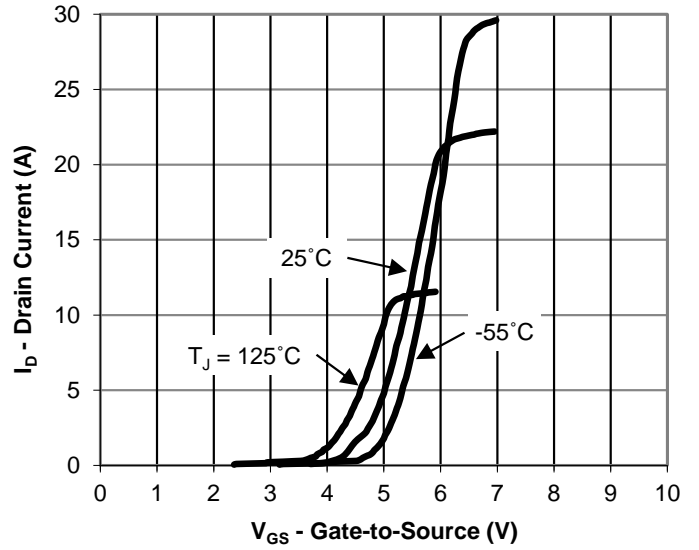
Reverse Diode

Continuous forward current	I_S	$V_{GS}=0\text{ V}$	-	-	6	A
Diode forward voltage	V_{SD}	$V_{GS}=0\text{ V}, I_S=I_F$	-	0.9	1.2	V
Reverse recovery time	t_{rr}	$V_{RR}=300\text{ V}, I_S=I_F,$ $d_{iF}/d_t=100\text{ A}/\mu\text{S}$	-	228	-	ns
Reverse recovery charge	Q_{rr}		-	2.4	-	μC
Peak reverse recovery current	I_{rm}		-	29	-	A

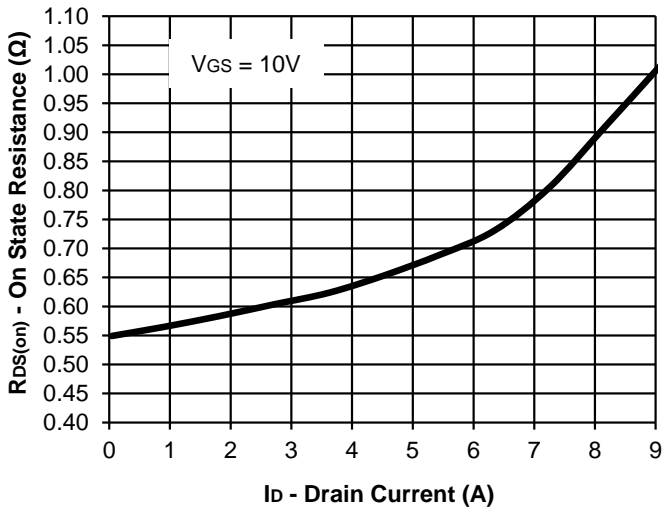
Output Characteristics



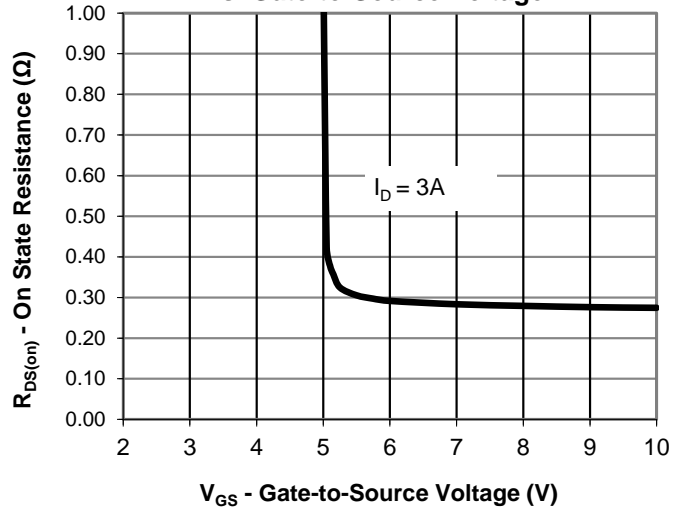
Transfer Characteristics



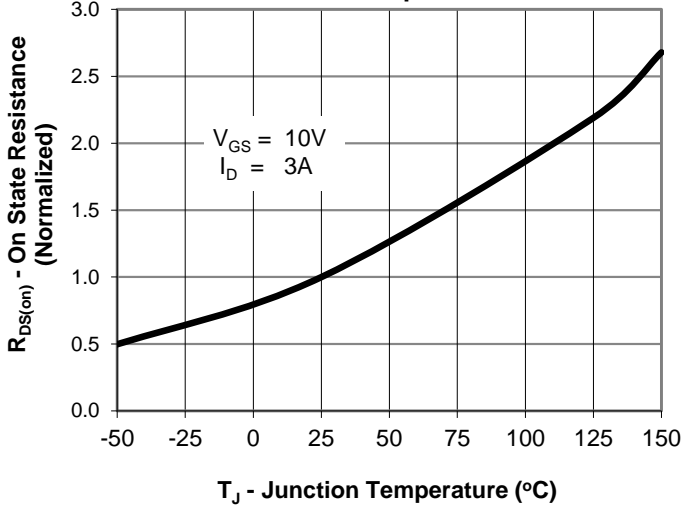
Drain - Source On-State Resistance vs. Drain Current



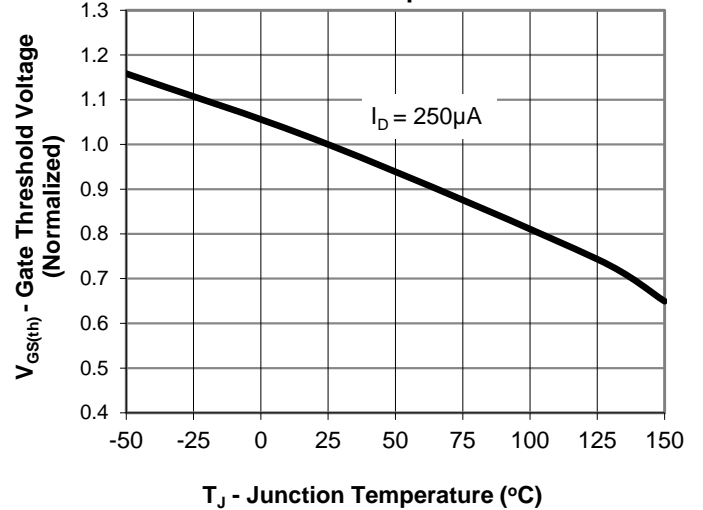
Drain-Source On-State Resistance vs. Gate-to-Source Voltage



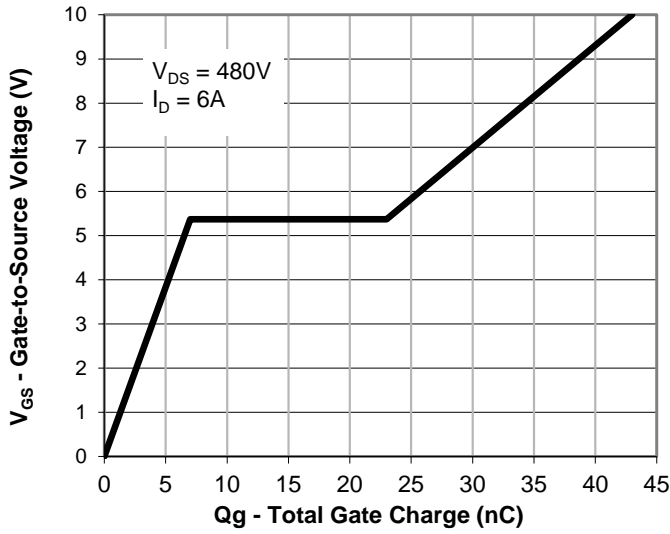
Drain-Source On State Resistance vs. Junction Temperature



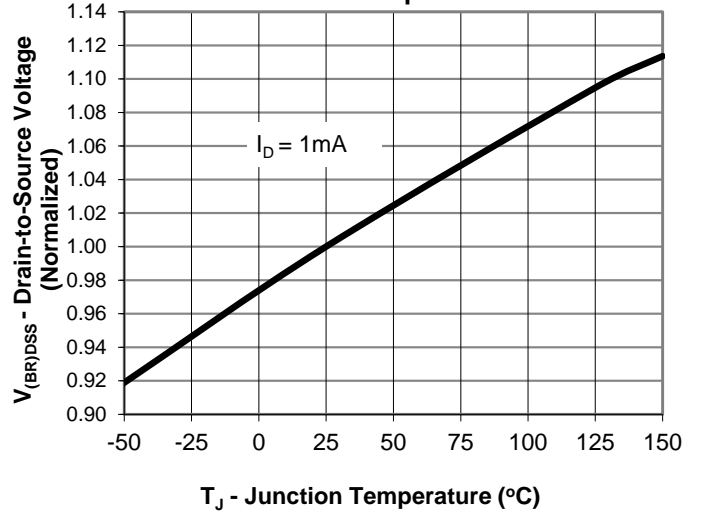
Gate Threshold Voltage vs. Junction Temperature



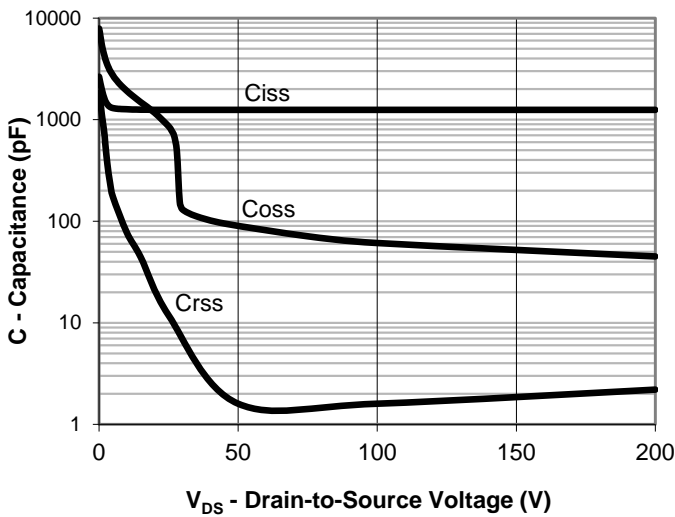
Gate Charge



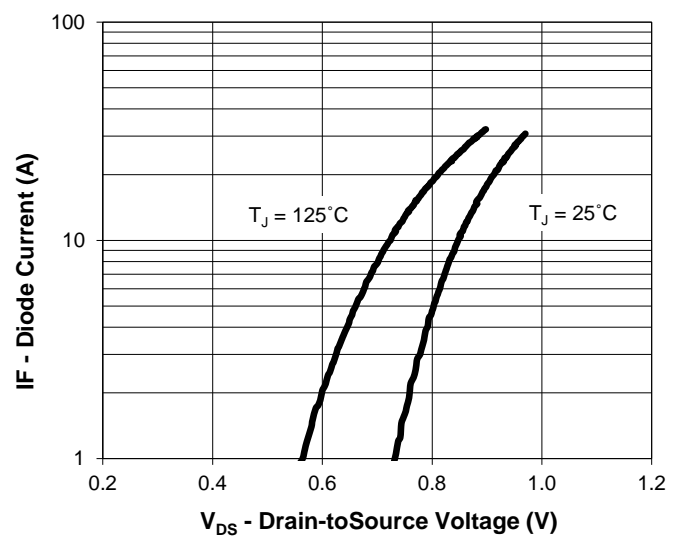
Drain-to-Source Breakdown Voltage vs. Junction Temperature



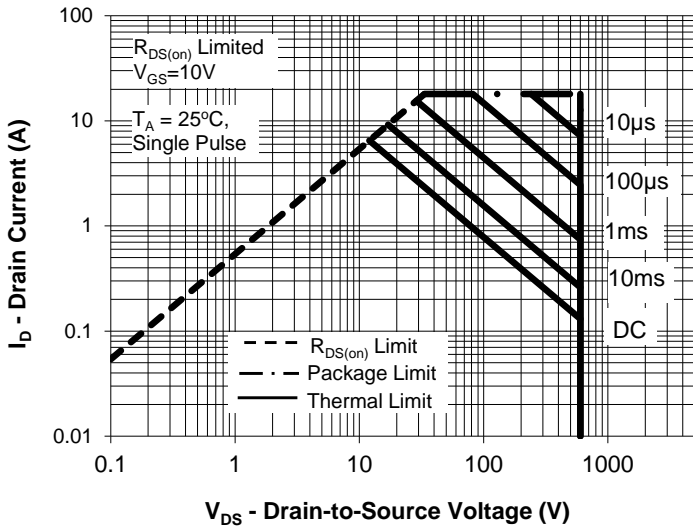
Capacitance



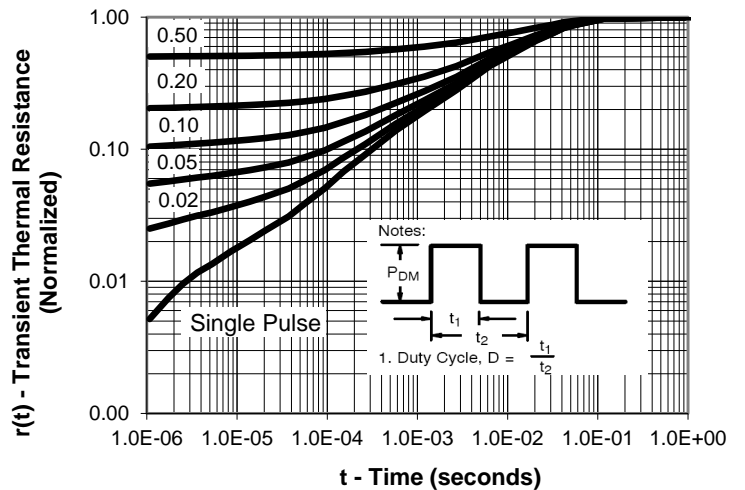
Drain-Source Diode Forward Voltage



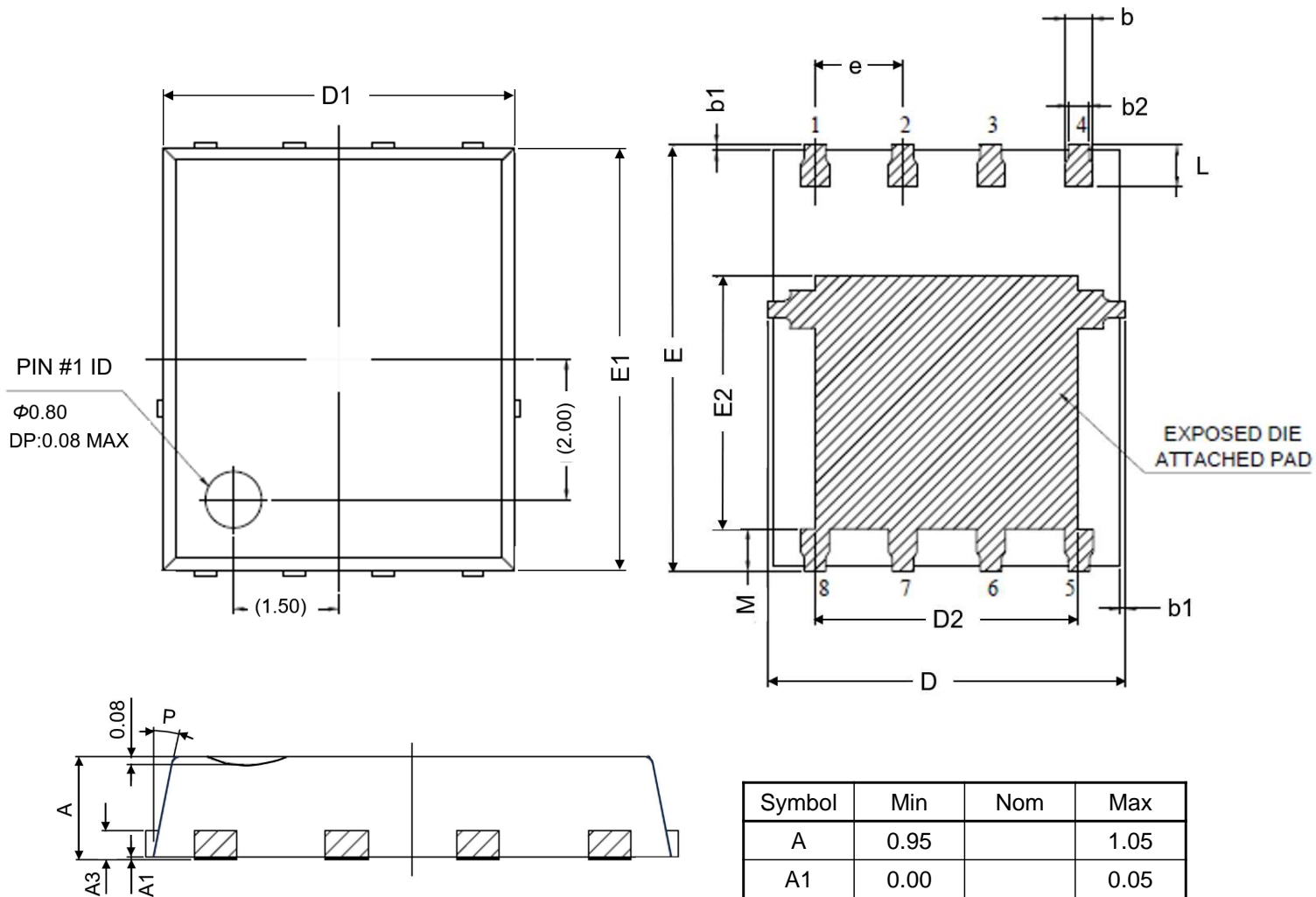
Maximum Rated Forward Biased Safe Operating Area



Transient Thermal Response, Junction-to-Case

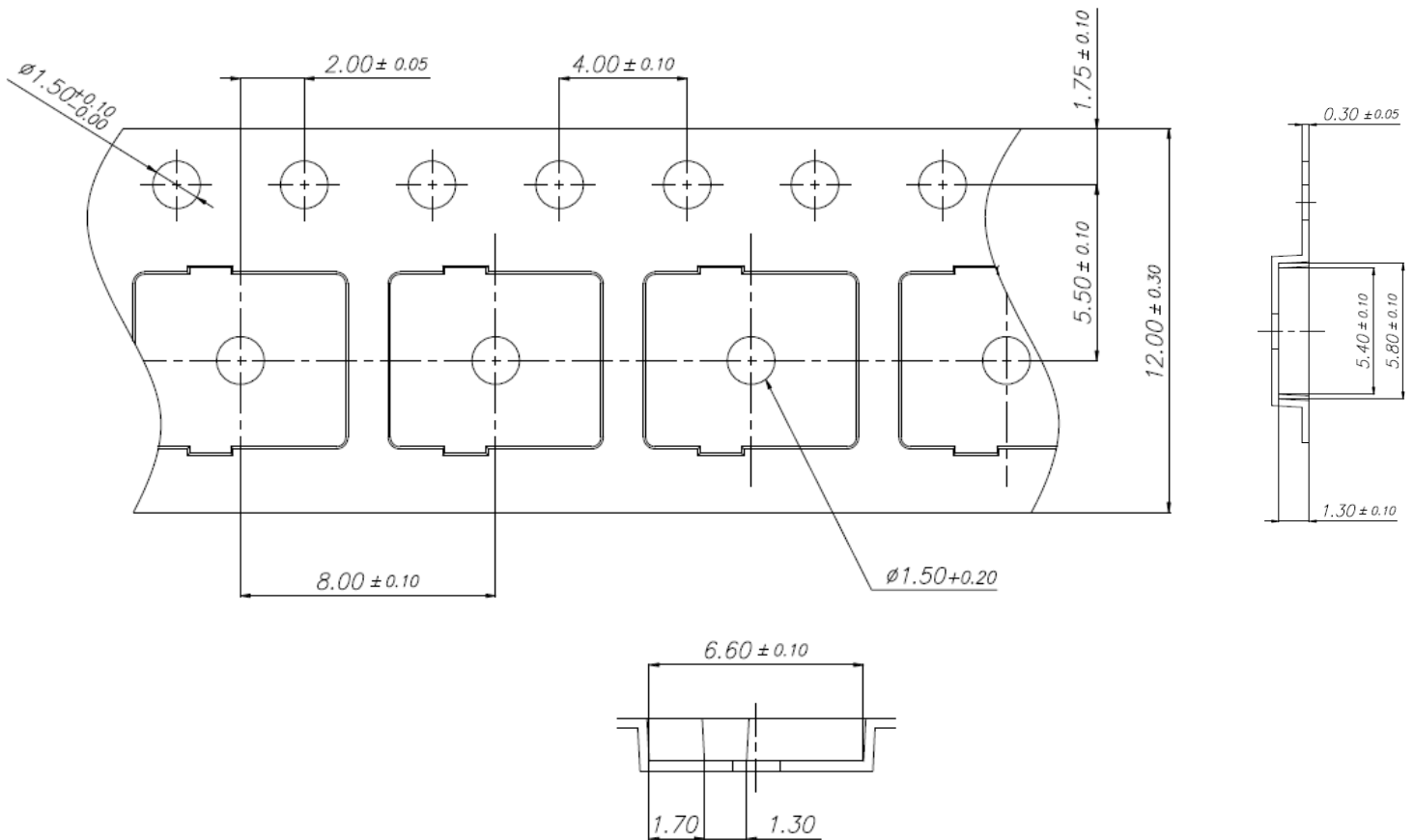


Package Outline

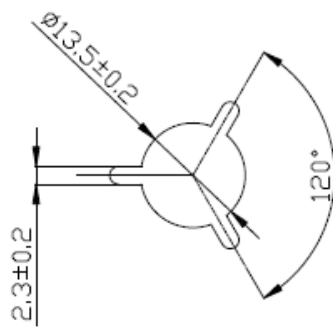
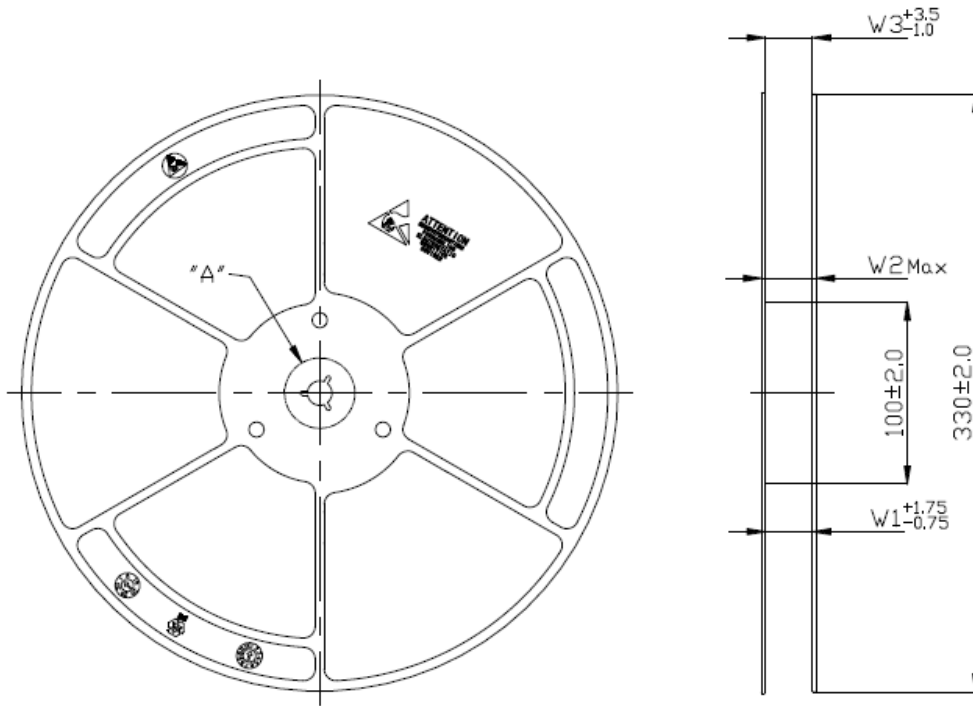


Symbol	Min	Nom	Max
A	0.95		1.05
A1	0.00		0.05
A3		0.25 REF	
b	0.31		0.51
b1	0.03		0.13
b2	0.21		0.41
D		5.15 BSC	
D1		5.00 BSC	
D2	3.7		3.9
E		6.15 BSC	
E1		6.00 BSC	
E2	3.56		3.76
e		1.27 BSC	
L	0.51		0.71
M	0.51		0.71
P	10°		12°

Tape and Reel Orientation



Reel and Reel Cap



“ A ”

$$W1 = 13.4$$

$$W2 = 19.5$$

$$W3 = 13.4$$

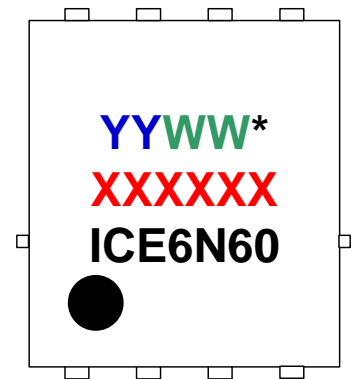
Marking Information

YY = Last two digits of the year

WW = Work week

***** = Site ID

XXXXXX = Lot ID



ICE6N60 = ICE is IceMOS logo and
6N60 is a designated device part number

Disclaimer

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